

<b>Issue Classification</b>		Application/Control No.	Applicant(s)/Patent under Reexamination
		09/632,466	MILAN ET AL.
		Examiner	Art Unit
		Kim T. Huynh	2112

ORIGINAL			CROSS REFERENCE(S)						
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
710	100	455	226						
INTERNATIONAL CLASSIFICATION									
G	D	6 F	13100						
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 Kim T. Huynh 10/26/05 (Assistant Examiner) (Date)			 REHANA PERVEEN SUPERVISORY PATENT EXAMINER (Primary Examiner) (Date) 10/26/05						
			Total Claims Allowed: 9						
			O.G. Print Claim(s)	35	O.G. Print Fig.	2			

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1		31		61		121	
2		32		62		122	
3		33		63		123	
4		34		64		124	
5		1 35		65		125	
6		2 36		66		126	
7		3 37		67		127	
8		4 38		68		128	
9		5 39		69		129	
10		6 40		70		130	
11		7 41		71		131	
12		8 42		72		132	
13		9 43		73		133	
14		44		74		134	
15		45		75		135	
16		46		76		136	
17		47		77		137	
18		48		78		138	
19		49		79		139	
20		50		80		140	
21		51		81		141	
22		52		82		142	
23		53		83		143	
24		54		84		144	
25		55		85		145	
26		56		86		146	
27		57		87		147	
28		58		88		148	
29		59		89		149	
30		60		90		150	